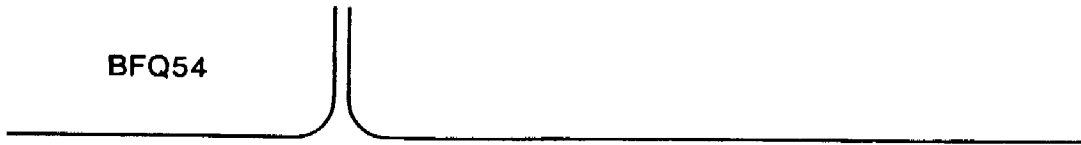


New Jersey Semi-Conductor Products, Inc.

20 STERN AVE.
 SPRINGFIELD, NEW JERSEY 07081
 U.S.A.

TELEPHONE: (973) 376-2922
 (212) 227-6005
 FAX: (973) 376-8960

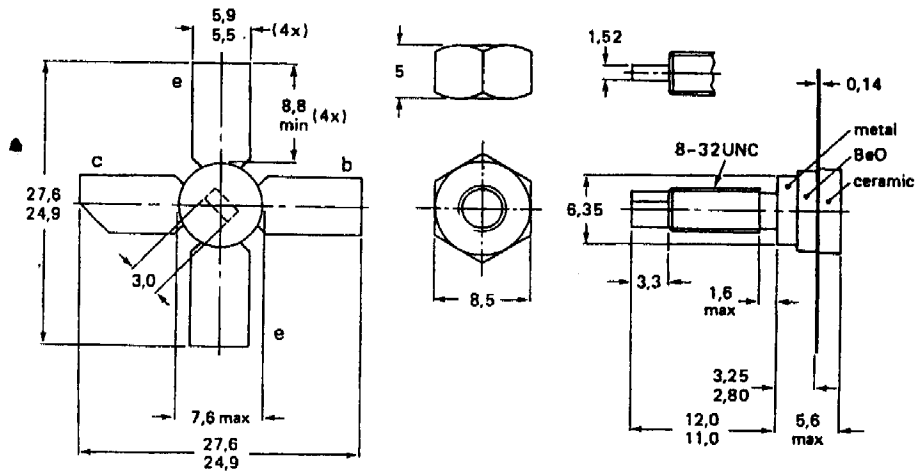


BFQ54

MECHANICAL DATA

Fig. 1 SOT122.

Dimensions in mm



Torque on nut: min. 0.75 Nm (7.5 kg cm) diameter of clearance hole in heatsink: max. 4.2 mm
 max. 0.85 Nm (8.5 kg cm) mounting hole to have no burrs at either end.
 de-burrings must leave surface flat; do not chamfer or countersink either end of the hole.

When locking is required an adhesive is preferred instead of a lock washer.

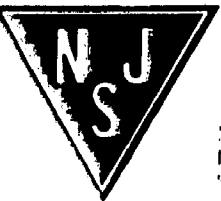
RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134).

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	25 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	18 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	2 V
Collector current (DC)	$-I_C$	max.	150 mA
Total power dissipation up to $T_{mb} = 125^\circ\text{C}$	P_{tot}	max.	2.25 W
Storage temperature range	T_{stg}		-65 to $+150^\circ\text{C}$
Operating junction temperature	T_j	max.	200°C

THERMAL RESISTANCE

From junction to mounting base	$R_{th\ j-mb}$	=	28 K/W
From mounting base to heatsink	$R_{th\ mb-h}$	=	0.6 K/W



CHARACTERISTICS

$T_{amb} = 25^{\circ}\text{C}$ unless otherwise specified

Collector cut-off current

$$I_E = 0; -V_{CB} = 15\text{ V}$$

I_{CBO} max. 50 μA

DC current gain

$$-I_C = 150\text{ mA}; -V_{CE} = 15\text{ V}$$

h_{FE} min. 25

h_{FE} typ. 75

Transition frequency at $f = 500\text{ MHz}$ (note 1)

$$-I_C = 150\text{ mA}; -V_{CE} = 15\text{ V}$$

f_T typ. 4.5 GHz

Collector capacitance at $f = 1\text{ MHz}$

$$I_E = I_C = 0; -V_{CB} = 15\text{ V}$$

C_C typ. 2.0 pF

Emitter capacitance at $f = 1\text{ MHz}$

$$I_C = I_E = 0; -V_{EB} = 0.5\text{ V}$$

C_e typ. 6.5 pF

Feedback capacitance at $f = 1\text{ MHz}$

$$I_C = 0\text{ mA}; V_{CE} = 15\text{ V}$$

C_{re} typ. 1.3 pF

Collector-stud capacitance

C_{cs} typ. 1.2 pF

Maximum unilateral power gain (S12 assumed to be zero)

$$-I_C = 120\text{ mA}; -V_{CE} = 15\text{ V}; f = 500\text{ MHz}$$

$$G_{UM} = 10 \log \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)}$$

G_{UM} typ. 16 dB

Output voltage at $d_{im} = -60\text{ dB}$

(DIN 45005B, para 6.3: 3-tone)

$$-I_C = 120\text{ mA}; -V_{CE} = 15\text{ V}; R_L = 75\ \Omega$$

$$V_p = V_o \text{ at } d_{im} = -60\text{ dB}; f_p = 795.25\text{ MHz}$$

$$V_q = V_o -6\text{ dB}; f_q = 803.25\text{ MHz}$$

$$V_r = V_o -6\text{ dB}; f_r = 805.25\text{ MHz}$$

$$\text{measured at } f_{(p+q-r)} = 793.25\text{ MHz}$$

V_o typ. 900 mV

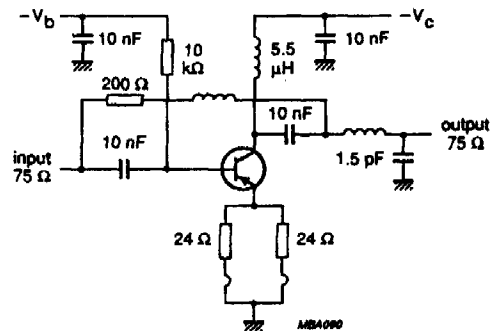


Fig. 2 MATV-test circuit $F = 40$ to 860 MHz

Note

1. Measured under pulse conditions.